



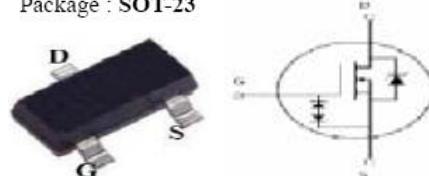
Silicon N-Channel Power MOSFET 
CSF501D

Features:

- | N-Channel
- | ESD improved Capability
- | Depletion Mode
- | dv/dt rated
- | Pb-free lead plating; ROHS compliant
- | Halogen Free

V _{DSX}	600	V
I _{DSS,min}	0.012	A
R _{DS(ON),max}	700	Ω

Package : SOT-23



Absolute (T_c= 25°C unless otherwise specified):

Symbol	Parameter	Rating	Units
V _{DSX}	Drain-to-Source Voltage	600	V
I _D	Continuous Drain Current	0.030	A
	Continuous Drain Current T _c =70 °C	0.024	A
I _{DM} ^{a1}	Pulsed Drain Current	0.120	A
V _{GS}	Gate-to-Source Voltage	±20	V
dv/dt ^{a2}	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	0.5	W
V _{ESD(G-S)}	Gate source ESD (HBM-C= 100pF, R=1.5kΩ)	300	V
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T _L	MaximumTemperature for Soldering	300	°C

Electrical Characteristics (T_c= 25°C unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSX}	Drain to Source Breakdown Voltage	V _{GS} =-5V, I _D =250μA	600	--	--	V
I _{D(off)}	Off-state Drain to Source Current	V _{DS} =600V, V _{GS} = -5V	--	--	0.1	μA
		V _{DS} =480V, V _{GS} = -5V Ta=125°C			10	μA
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} =+10V	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} =-10V	--	--	-100	nA



CSF501D



ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
Idss	On-state drain current	V _{GS} =0V, V _{DS} =25V	12			mA
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =0V, I _D =3mA	--	350	700	Ω
		V _{GS} =10V, I _D =16mA		400	800	
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} = 3V, I _D = 8.0μA	-2.7	-1.8	-1.0	V

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g _{fs}	Forward Transconductance	V _{DS} =50V, I _D = 0.01A	0.008	0.017	--	S
C _{iss}	Input Capacitance	V _{GS} = -5V V _{DS} = 25V f = 1.0MHz	--	50		pF
C _{oss}	Output Capacitance		--	4.53		
C _{rss}	Reverse Transfer Capacitance		--	1.08		

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D = 0.01A V _{DD} = 300V V _{GS} = -5...7V R _G = 6.0Ω	--	9.9	--	ns
t _r	Rise Time		--	55.8	--	
t _{d(OFF)}	Turn-Off Delay Time		--	56.4	--	
t _f	Fall Time		--	136	--	
Q _g	Total Gate Charge	I _D = 0.01A V _{DD} = 400V V _{GS} = -5V to 5V	--	1.14		nC
Q _{gs}	Gate to Source Charge		--	0.5		
Q _{gd}	Gate to Drain ("Miller")Charge		--	0.37		

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)	Ta=25° C	--	--	0.025	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	0.100	A
V _{SD}	Diode Forward Voltage	I _F =16mA, V _{GS} =-5V	--	--	1.2	V
trr	Reverse Recovery Time	I _F =0.01A, T _j = 25° C	--	243	--	ns
Qrr	Reverse Recovery Charge	dI _F /dt=100A/us, V _R =300V	--	636	--	nC

Symbol	Parameter	Typ.	Units
R _{θ JA}	Junction-to-Ambient	250	°C/W



CSF501D



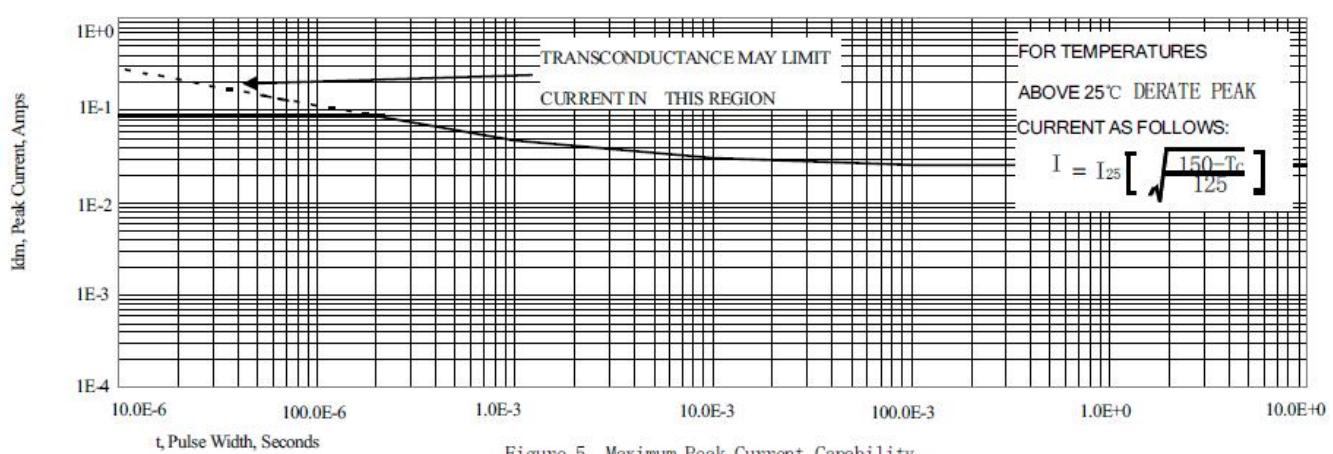
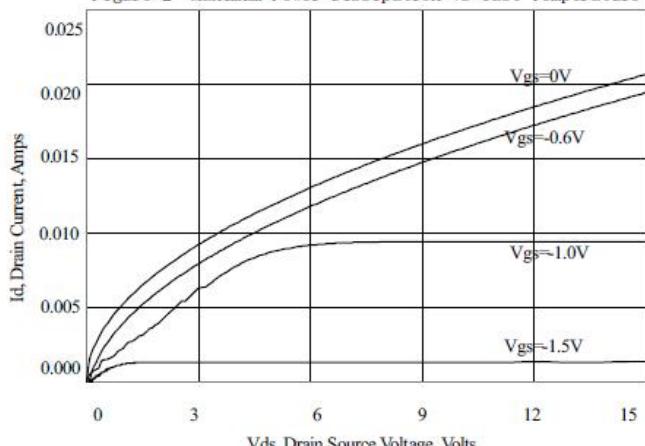
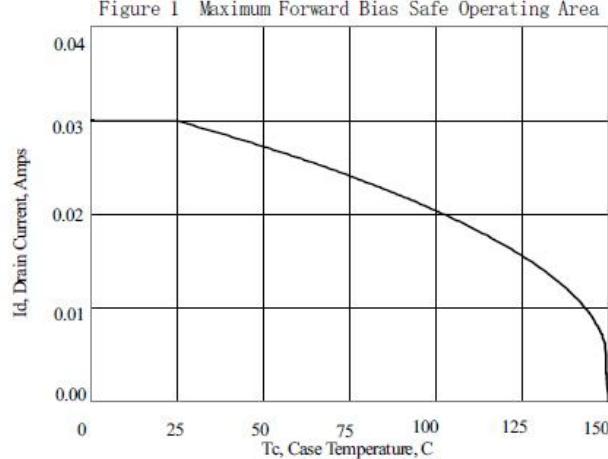
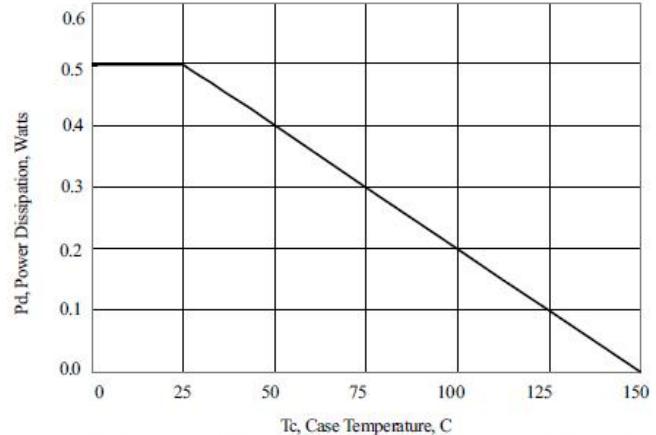
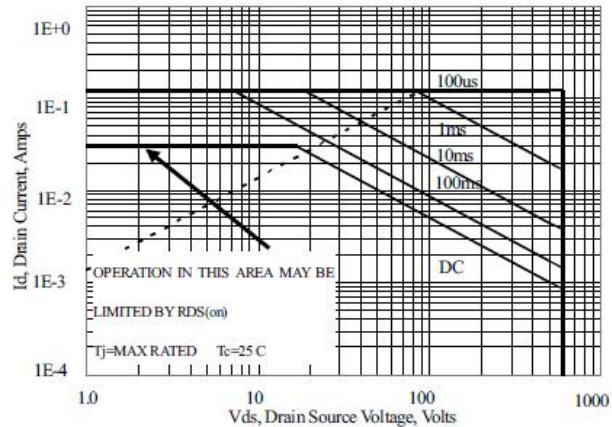
Gate-source Zener diode						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1\text{mA}$ (Open Drain)	20			V
The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.						

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

^{a2}: $I_F = 0.01\text{A}, dI/dt \leq 100\text{A}/\mu\text{s}, V_{DD} \leq BV_{DS}$, Start $T_J = 25^\circ\text{C}$



Characteristics Curve:





CSF501D

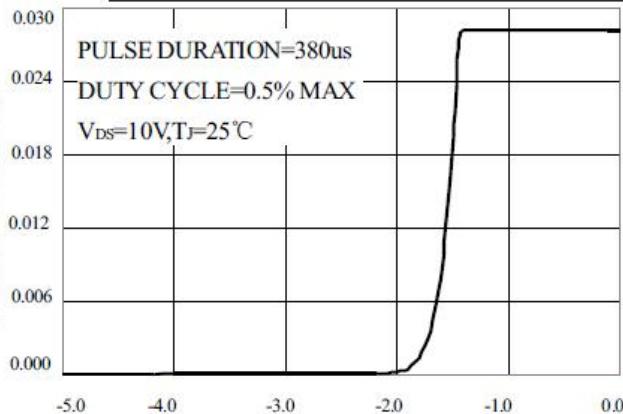


Figure 6 Typical Transfer Characteristics

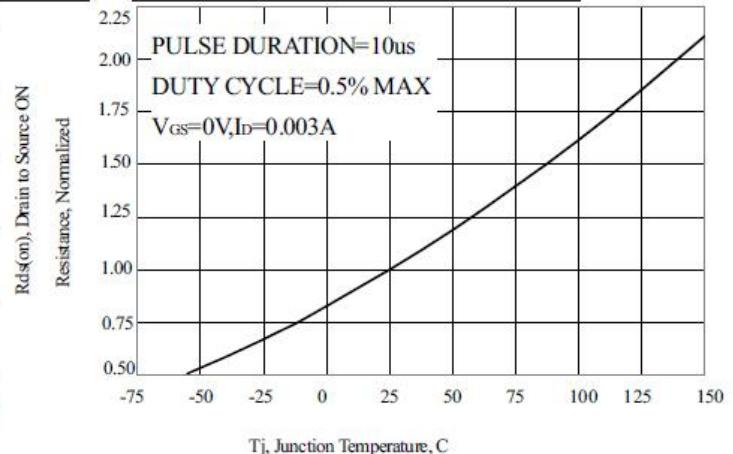


Figure 7 Typical Drain to Source ON Resistance vs Junction Temperature

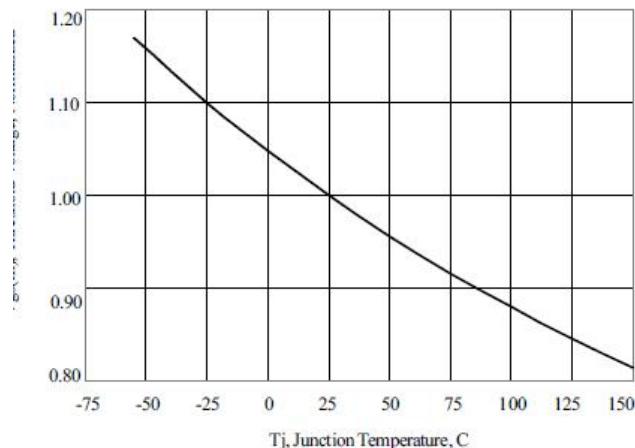


Figure 8 Typical Threshold Voltage vs Junction Temperature

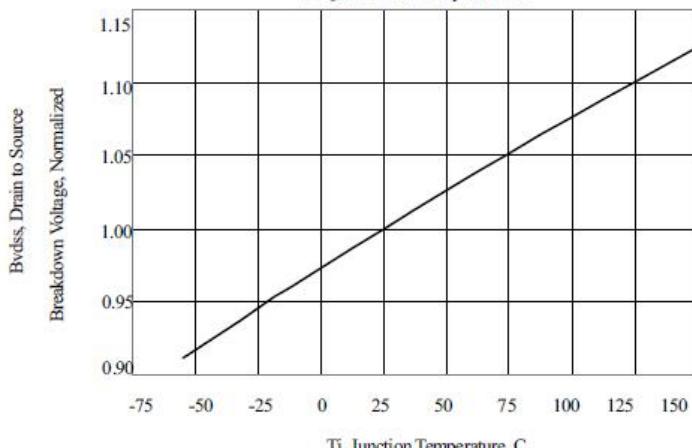


Figure 9 Typical Breakdown Voltage vs Junction Temperature

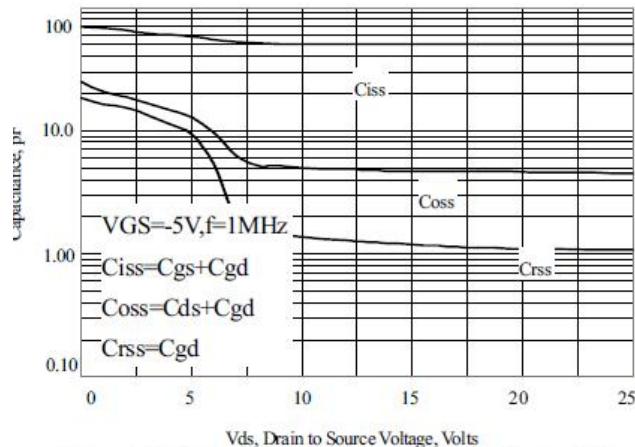


Figure 10 Typical Capacitance vs Drain to Source Voltage

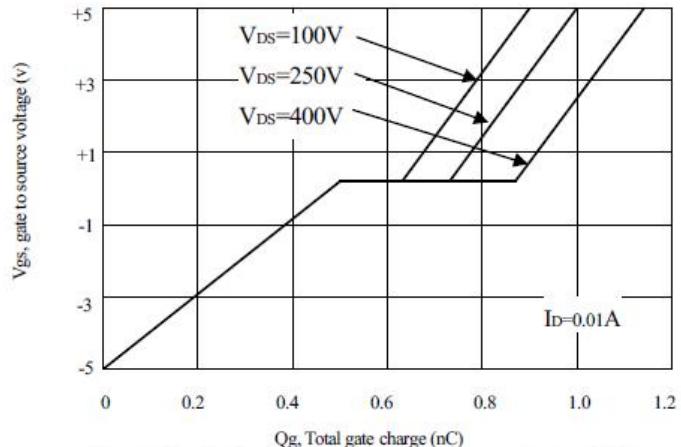


Figure 11 Typical Gate Charge vs Gate to Source Voltage



CSF501D

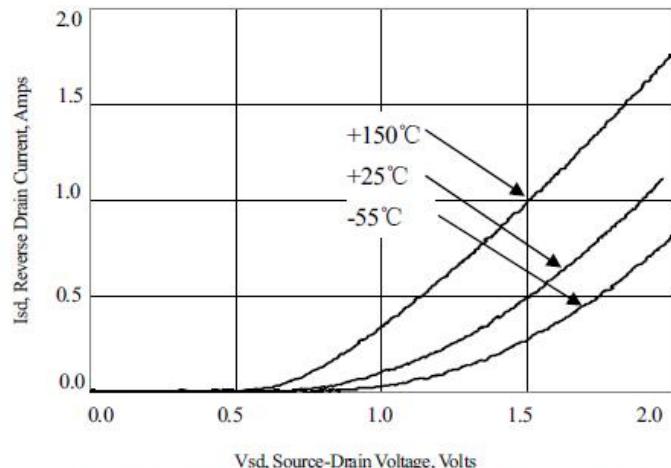
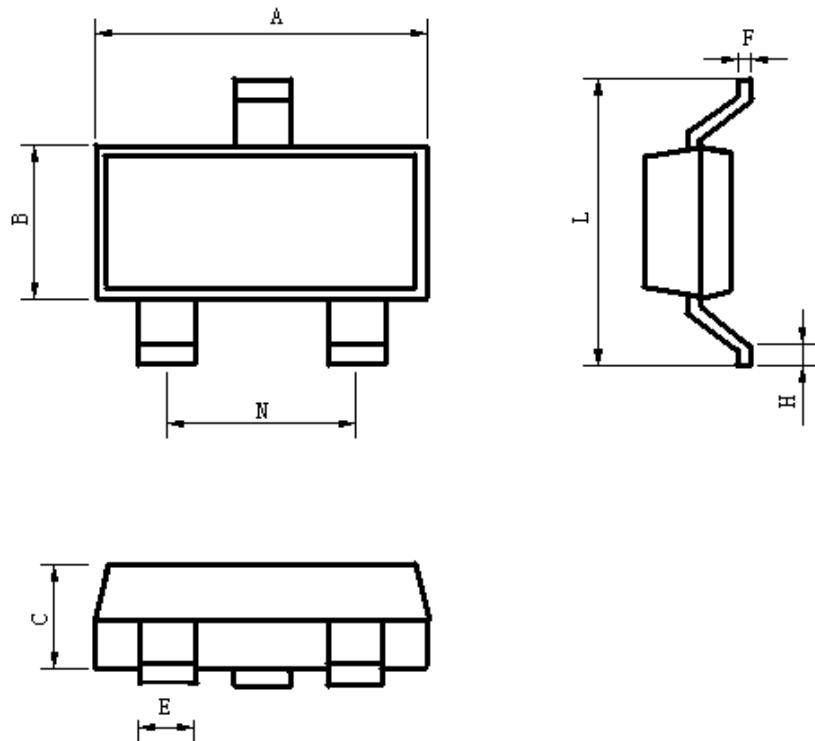


Figure 12 Typical Body Diode Transfer Characteristics

Package Information:

项 目	规范(mm)	
	MIN	MAX
A	2.70	3.10
B	1.20	1.40
C	0.90	1.10
E	0.30	0.50
F	0.05	0.15
H	0.30	0.50
L	2.10	2.70
N	1.80	2.00

SOT-23 Package

**The name and content of poisonous and harmful material in products**

Part's Name	Hazardous Substance					
	Pb	Hg	Cd	Cr(VI)	PBB	PBDE
Limit	≤0.1%	≤0.1%	≤0.01%	≤0.1%	≤0.1%	≤0.1%
Lead Frame	○	○	○	○	○	○
Molding Compound	○	○	○	○	○	○
Chip	○	○	○	○	○	○
Wire Bonding	○	○	○	○	○	○
Solder	×	○	○	○	○	○
Note	<p>○: means the hazardous material is under the criterion of SJ/T11363-2006.</p> <p>×: means the hazardous material exceeds the criterion of SJ/T11363-2006.</p> <p>The plumbum element of solder exist in products presently, but within the allowed range of Eurogroup's RoHS.</p>					

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
2. When installing the heatsink, please pay attention to the torsional moment and the smoothness of the heatsink.
3. VDMOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

WUXI CHINA RESOURCES HUAJING MICROELECTRONICS CO., LTD.

Add: No.14 Liangxi RD. Wuxi, Jiangsu, China Mail:214061 <http://www.crhj.com.cn>
Tel: +86 0510-85807228 Fax: +86- 0510-85800864

Marketing Part: Post: 214061 Tel: +86 0510-81805277/81805336
Fax: +86 0510-85800360/85803016
E-mail: sales@hj.crmicro.com

Application and Service: Post: 214061 Tel / Fax: +86- 0510-81805243/81805110